

Is Now Part of

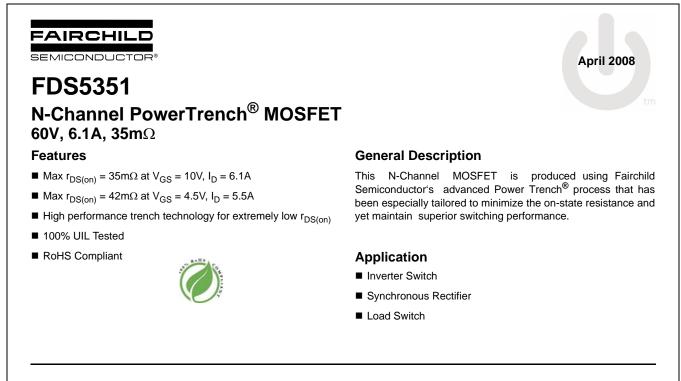


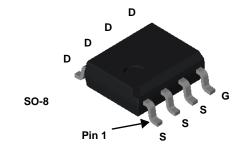
ON Semiconductor®

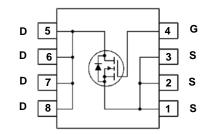
To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor date sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdicii on or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor reducts for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, and filiates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended o







MOSFET Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DS}	Drain to Source Voltage		60	V
V _{GS}	Gate to Source Voltage		±20	V
ID	Drain Current -Continuous		6.1	٨
	-Pulsed		30	— A
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	73	mJ
P _D	Power Dissipation $T_A = 25^{\circ}C$	(Note 1a)	5	w
	Power Dissipation $T_A = 25^{\circ}C$	(Note 1b)	2.5	vv
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R_{\thetaJC}	Thermal Resistance, Junction to Case	(Note 1)	25	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS5351	FDS5351	SO-8	13"	12mm	2500units

Downloaded from Arrow.com.

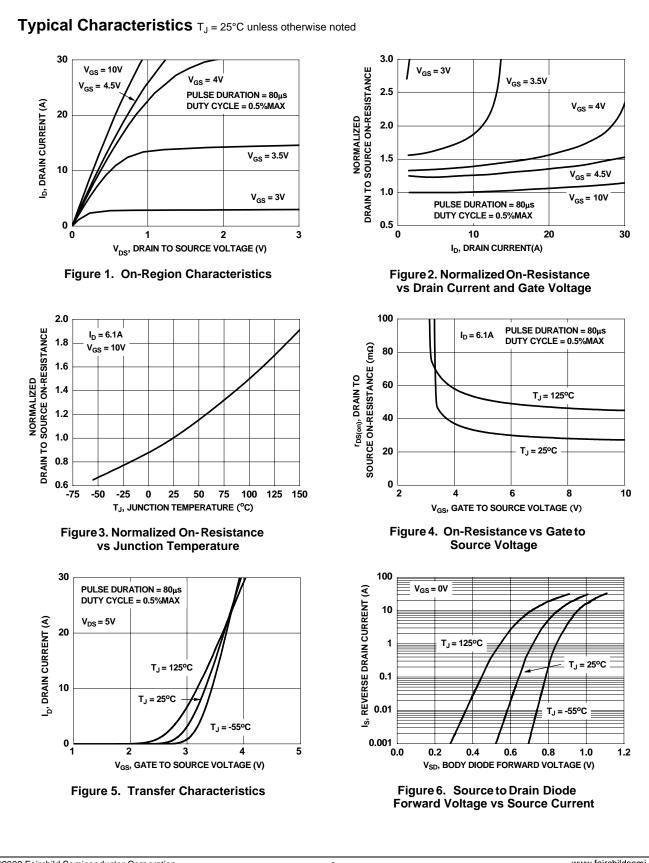
FDS5351 N-Channel PowerTrench[®] MOSFET

Parameter	Test Conditions	Min	Тур	Max	Units
cteristics					
Drain to Source Breakdown Voltage	$I_{D} = 250 \mu A$, $V_{CS} = 0 V$	60			V
					-
Coefficient	$I_D = 250\mu A$, referenced to $25^{\circ}C$		55		mV/°C
Zero Gate Voltage Drain Current	$V_{DS} = 48V, V_{GS} = 0V$			1	μA
Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
cteristics					
Gate to Source Threshold Voltage	$V_{CS} = V_{DS}$. $I_{D} = 250 \mu A$	1.0	2.0	3.0	V
Gate to Source Threshold Voltage			6.0		
Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25°C		-6.2		mV/°C
	$V_{GS} = 10V, I_D = 6.1A$		26.5	35.0	
Static Drain to Source On Resistance	V _{GS} = 4.5V, I _D = 5.5A		32.4	42.0	mΩ
	$V_{GS} = 10V, I_D = 6.1A, T_J = 125^{\circ}C$		44.5	58.8	
Forward Transconductance	$V_{DD} = 5V, I_D = 6.1A$		24		S
Characteristics					
			085	1310	pF
	V _{DS} = 30V, V _{GS} = 0V, f = 1MHz				pr
				-	pF
	f – 1MHz			15	Ω
g Characteristics					
Turn-On Delay Time			8	16	ns
Rise Time			3	10	ns
Turn-Off Delay Time	$V_{GS} = 10^{\circ}, R_{GEN} = 602$		21	34	ns
Fall Time			2	10	ns
Total Gate Charge	$V_{GS} = 0V$ to 10V		19	27	nC
Total Gate Charge	$V_{GS} = 0V \text{ to } 4.5V$ $V_{DD} = 30V,$		9	13	nC
Gate to Source Charge	I <u>J</u> = 0.1A		3		nC
Gate to Drain "Miller" Charge			3.5		nC
urce Diode Characteristics					
		1	0.82	1.3	
	$V_{00} = (V_{10} = 6.1A)$ (Note 2)				V
Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 6.1A$ (Note 2) $V_{CS} = 0V, I_S = 2.1A$ (Note 2)				V
Source to Drain Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 0V, I_S = 6.1A $ (Note 2) $V_{GS} = 0V, I_S = 2.1A $ (Note 2) $I_F = 6.1A, di/dt = 100A/\mu s$		0.76	1.2 38	- V ns
	Zero Gate Voltage Drain Current Gate to Source Leakage Current Cteristics Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On Resistance Forward Transconductance Forward Transconductance Characteristics Input Capacitance Output Capacitance Output Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	Breakdown Voltage Temperature Coefficient $I_D = 250\mu$ A, referenced to 25°CZero Gate Voltage Drain Current $V_{DS} = 48V$, $V_{GS} = 0V$ Gate to Source Leakage Current $V_{GS} = \pm 20V$, $V_{DS} = 0V$ CteristicsGate to Source Threshold Voltage Temperature Coefficient $V_{GS} = V_{DS}$, $I_D = 250\mu$ AGate to Source Threshold Voltage Temperature Coefficient $I_D = 250\mu$ A, referenced to 25°CStatic Drain to Source On Resistance $V_{GS} = 10V$, $I_D = 6.1A$ Static Drain to Source On Resistance $V_{GS} = 10V$, $I_D = 6.1A$, $T_J = 125°C$ Forward Transconductance $V_{DD} = 5V$, $I_D = 6.1A$ CharacteristicsInput Capacitance Gate ResistanceInput Capacitance Gate Resistance $V_{DS} = 30V$, $V_{GS} = 0V$, $f = 1MHz$ fFame Fame Tum-On Delay Time Fall TimeTurn-Off Delay Time Fall Time $V_{GS} = 0V$ to $10V$ $V_{GS} = 0V$ to $4.5V$ Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge $V_{GS} = 0V$ to $4.5V$	Breakdown Voltage Temperature Coefficient $I_D = 250\mu A$, referenced to $25^{\circ}C$ Zero Gate Voltage Drain Current $V_{DS} = 48V$, $V_{GS} = 0V$ Gate to Source Leakage Current $V_{GS} = \pm 20V$, $V_{DS} = 0V$ CteristicsGate to Source Threshold Voltage Temperature Coefficient $V_{GS} = V_{DS}$, $I_D = 250\mu A$ 1.0Gate to Source Threshold Voltage Temperature Coefficient $I_D = 250\mu A$, referenced to $25^{\circ}C$ 1.0Static Drain to Source On Resistance $V_{GS} = 10V$, $I_D = 6.1A$ $V_{GS} = 10V$, $I_D = 6.1A$ Static Drain to Source On Resistance $V_{DD} = 5V$, $I_D = 6.1A$ $V_{CS} = 10V$, $I_D = 6.1A$ CharacteristicsInput Capacitance $V_{DS} = 30V$, $V_{GS} = 0V$, $f = 1MHz$ I_D Gate Resistancef = 1MHzInput Capacitance $V_{DS} = 30V$, $I_D = 6.1A$, $V_{CS} = 10V$, $I_D = 6.1A$ Turn-On Delay Time $V_{DD} = 30V$, $I_D = 6.1A$, $V_{GS} = 10V$, $R_{GEN} = 6\Omega$ $I_D = 100000000000000000000000000000000000$	$\begin{tabular}{ c l l l l l l l l l l l l$	$\begin{tabular}{ c c c c c c } \hline Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$, referenced to 25°C $$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$$

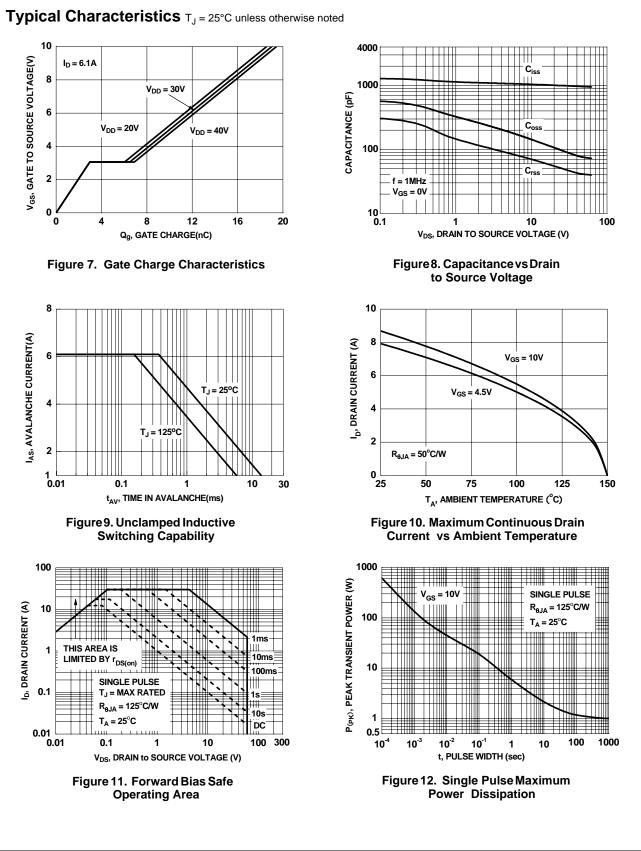
2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

3. UIL condition: Starting $T_J = 25^{\circ}C$, L = 3mH, $I_{AS} = 7A$, $V_{DD} = 60V$, $V_{GS} = 10V$.

©2008 Fairchild Semiconductor Corporation FDS5351 Rev.C

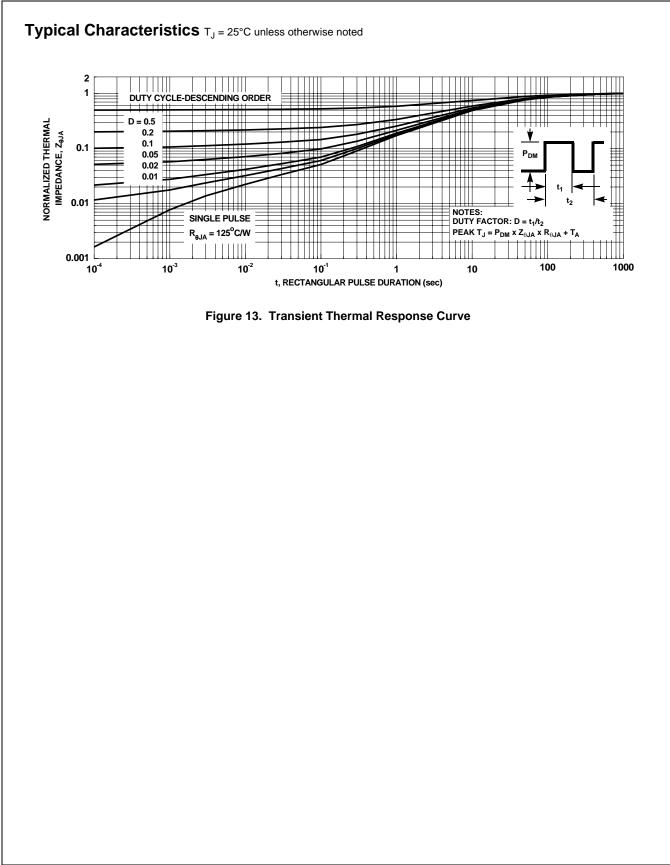


©2008 Fairchild Semiconductor Corporation FDS5351 Rev.C



©2008 Fairchild Semiconductor Corporation FDS5351 Rev.C

FDS5351 N-Channel PowerTrench[®] MOSFET



©2008 Fairchild Semiconductor Corporation FDS5351 Rev.C



SEMICONDUCTOR

TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidianries, and is not intended to be an exhaustive list of all such trademarks.

ACEx® FPS™ PDP-SPM™ The Power Franchise[®] Power-SPM™ F-PFS™ Build it Now™ bwer p) CorePLUS™ FRFET® PowerTrench[®] franchise CorePOWER™ Global Power ResourceSM Programmable Active Droop™ TinvBoost™ **QFET[®]** CROSSVOLT™ Green FPS™ TinyBuck™ CTL™ Green FPS[™] e-Series[™] QS™ TinyLogic® GTO™ TINYOPTO™ Current Transfer Logic™ Quiet Series™ TinyPower™ **EcoSPARK**[®] IntelliMAX™ RapidConfigure™ EfficentMax™ **ISOPLANAR**[™] Saving our world 1mW at a time™ TinyPWM™ EZSWITCH™ * MegaBuck™ SmartMax™ TinyWire™ µSerDes™ MICROCOUPLER™ SMART START™ SPM® MicroFET™ W MicroPak™ STEALTH™ airchild® UHC® MillerDrive™ SuperFET™ Fairchild Semiconductor® MotionMax[™] SuperSOT™-3 Ultra FRFET™ FACT Quiet Series™ Motion-SPM[™] SuperSOT™-6 UniFET™ **OPTOLOGIC**[®] SuperSOT™-8 FACT® VCX™ FAST® **OPTOPLANAR[®]** SuperMOS™ VisualMax™ FastvCore™ FlashWriter[®] *

* EZSWITCH™ and FlashWriter[®] are trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS	
Definition of Terms	

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data; supplementary data will be pub- lished at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	This datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Downloaded from Arrow.com.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC

Downloaded from Arrow.com.